

## N-Channel 20 V (D-S) MOSFET

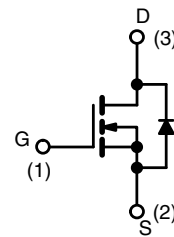
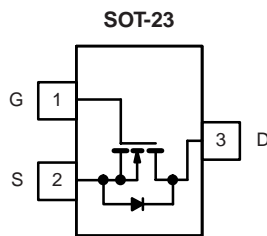
PRODUCT SUMMARY	
$V_{DS}$ (V)	20
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 4.5V$	0.020
$R_{DS(on)}$ ( $\Omega$ ) at $V_{GS} = 2.5V$	0.025
$Q_g$ typ. (nC)	4.0
$I_D$ (A) <sup>a, e</sup>	6
Configuration	Single

### FEATURES

- TrenchFET<sup>®</sup> power MOSFET
- Low on-resistance
- 100 %  $R_g$  tested
- Material categorization:  
for definitions of compliance please see



**RoHS**  
COMPLIANT



N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS ( $T_A = 25\text{ }^\circ\text{C}$ , unless otherwise noted)			
PARAMETER	SYMBOL	LIMIT	UNIT
Drain-source voltage	$V_{DS}$	20	V
Gate-source voltage	$V_{GS}$	$\pm 12$	
Continuous drain current ( $T_J = 150\text{ }^\circ\text{C}$ )	$I_D$	$T_C = 25\text{ }^\circ\text{C}$	A
		$T_C = 70\text{ }^\circ\text{C}$	
		$T_A = 25\text{ }^\circ\text{C}$	
		$T_A = 70\text{ }^\circ\text{C}$	
Pulsed drain current ( $t = 300\text{ }\mu\text{s}$ )	$I_{DM}$	26	
Continuous source-drain diode current	$I_S$	$T_C = 25\text{ }^\circ\text{C}$	W
		$T_A = 25\text{ }^\circ\text{C}$	
Maximum power dissipation	$P_D$	$T_C = 25\text{ }^\circ\text{C}$	W
		$T_C = 70\text{ }^\circ\text{C}$	
		$T_A = 25\text{ }^\circ\text{C}$	
		$T_A = 70\text{ }^\circ\text{C}$	
Operating junction and storage temperature range	$T_J, T_{stg}$	-55 to +150	$^\circ\text{C}$
Soldering recommendations (peak temperature)		260	

THERMAL RESISTANCE RATINGS					
PARAMETER	SYMBOL	TYPICAL	MAXIMUM	UNIT	
Maximum junction-to-ambient <sup>b, d</sup>	$R_{thJA}$	75	100	$^\circ\text{C/W}$	
Maximum junction-to-foot (drain)	$R_{thJF}$	40	50		

### Notes

- Based on  $T_C = 25\text{ }^\circ\text{C}$
- Surface mounted on 1" x 1" FR4 board
- $t = 5\text{ s}$
- Maximum under steady state conditions is  $166\text{ }^\circ\text{C/W}$
- Package limited

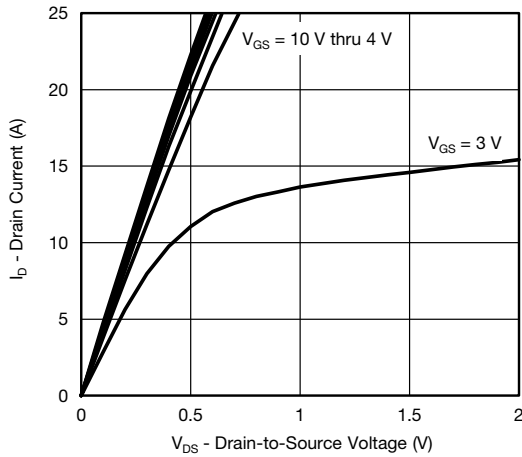
SPECIFICATIONS (T <sub>J</sub> = 25 °C, unless otherwise noted)						
PARAMETER	SYMBOL	TEST CONDITIONS	MIN.	TYP.	MAX.	UNIT
<b>Static</b>						
Drain-source breakdown voltage	V <sub>DS</sub>	V <sub>GS</sub> = 0 V, I <sub>D</sub> = 250 μA	20	-	-	V
V <sub>DS</sub> temperature coefficient	ΔV <sub>DS</sub> /T <sub>J</sub>	I <sub>D</sub> = 250 μA	-	30	-	mV/°C
V <sub>GS(th)</sub> temperature coefficient	ΔV <sub>GS(th)</sub> /T <sub>J</sub>		-	-4.8	-	
Gate-source threshold voltage	V <sub>GS(th)</sub>	V <sub>DS</sub> = V <sub>GS</sub> , I <sub>D</sub> = 250 μA	0.5	-	1.5	V
Gate-source leakage	I <sub>GSS</sub>	V <sub>DS</sub> = 0 V, V <sub>GS</sub> = ± 20 V	-	-	± 100	nA
Zero gate voltage drain current	I <sub>DSS</sub>	V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0 V	-	-	1	μA
		V <sub>DS</sub> = 20V, V <sub>GS</sub> = 0 V, T <sub>J</sub> = 70 °C	-	-	10	
On-state drain current <sup>a</sup>	I <sub>D(on)</sub>	V <sub>DS</sub> ≤ 5 V, V <sub>GS</sub> = 10 V	20	-	-	A
Drain-source on-state resistance <sup>a</sup>	R <sub>DS(on)</sub>	V <sub>GS</sub> = 4.5V, I <sub>D</sub> = 5.5 A	-	0.020	-	Ω
		V <sub>GS</sub> = 2.5 V, I <sub>D</sub> = 5 A	-	0.025	-	
Forward transconductance <sup>a</sup>	g <sub>fs</sub>	V <sub>DS</sub> = 15 V, I <sub>D</sub> = 5.5 A	-	24	-	S
<b>Dynamic <sup>b</sup></b>						
Input capacitance	C <sub>iss</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	-	900	-	pF
Output capacitance	C <sub>oss</sub>		-	100	-	
Reverse transfer capacitance	C <sub>rss</sub>		-	42	-	
Total gate charge	Q <sub>g</sub>	V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 10 V, I <sub>D</sub> = 5.5 A	-	8.2	13	nC
		V <sub>DS</sub> = 10 V, V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 5.5 A	-	4.2	7	
Gate-source charge	Q <sub>gs</sub>		-	1.4	-	
Gate-drain charge	Q <sub>gd</sub>		-	1.4	-	
Gate resistance	R <sub>g</sub>	f = 1 MHz	2.5	12.6	25.2	Ω
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, R <sub>L</sub> = 3.4 Ω I <sub>D</sub> ≅ 4.4 A, V <sub>GEN</sub> = 4.5 V, R <sub>g</sub> = 1 Ω	-	6	12	ns
Rise time	t <sub>r</sub>		-	20	30	
Turn-off delay time	t <sub>d(off)</sub>		-	14	21	
Fall time	t <sub>f</sub>		-	10	20	
Turn-on delay time	t <sub>d(on)</sub>	V <sub>DD</sub> = 10 V, R <sub>L</sub> = 3.4 Ω I <sub>D</sub> ≅ 4.4 A, V <sub>GEN</sub> = 10 V, R <sub>g</sub> = 1 Ω	-	3	6	
Rise time	t <sub>r</sub>		-	11	20	
Turn-off delay time	t <sub>d(off)</sub>		-	20	30	
Fall time	t <sub>f</sub>		-	7	14	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous source-drain diode current	I <sub>S</sub>	T <sub>C</sub> = 25 °C	-	7	-	A
Pulse diode forward current	I <sub>SM</sub>		-	-	25	
Body diode voltage	V <sub>SD</sub>	I <sub>S</sub> = 4.4 A, V <sub>GS</sub> = 0 V	-	0.82	1.2	V
Body diode reverse recovery time	t <sub>rr</sub>	I <sub>F</sub> = 4.4 A, di/dt = 100 A/μs, T <sub>J</sub> = 25 °C	-	13	20	ns
Body diode reverse recovery charge	Q <sub>rr</sub>		-	6	12	nC
Reverse recovery fall time	t <sub>a</sub>		-	8	-	ns
Reverse recovery rise Time	t <sub>b</sub>		-	5	-	

**Notes**

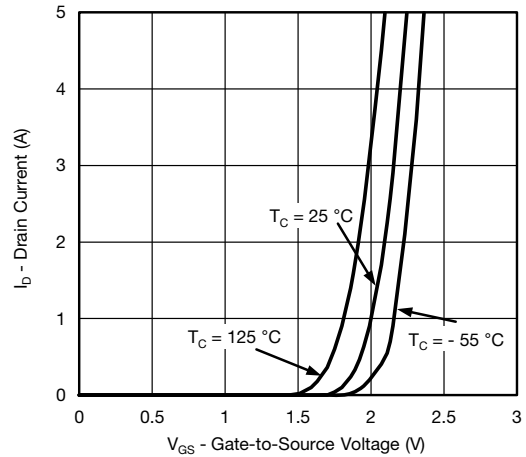
- a. Pulse test; pulse width ≤ 300 μs, duty cycle ≤ 2 %
- b. Guaranteed by design, not subject to production testing

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

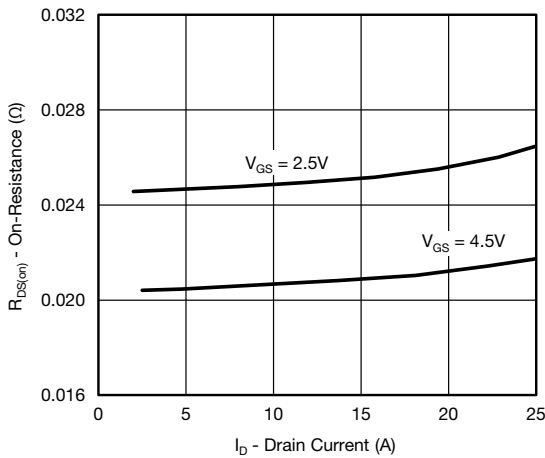
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



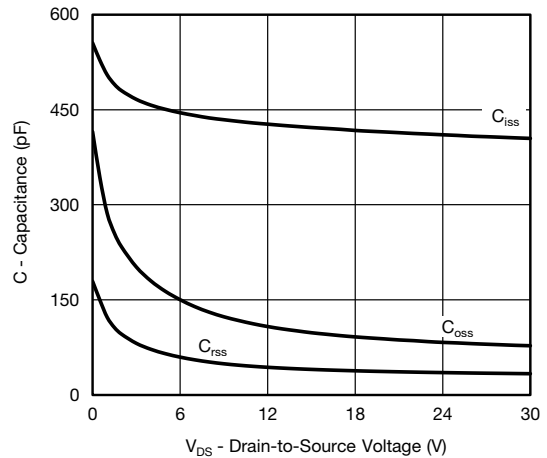
**Output Characteristics**



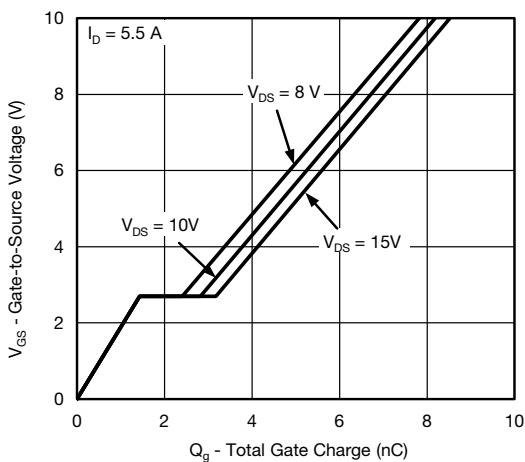
**Transfer Characteristics**



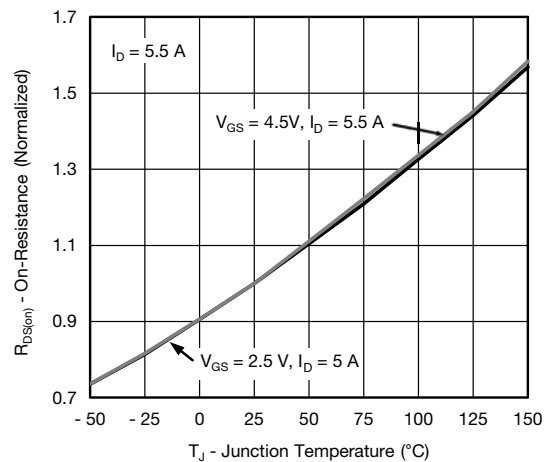
**On-Resistance vs. Drain Current and Gate Voltage**



**Capacitance**

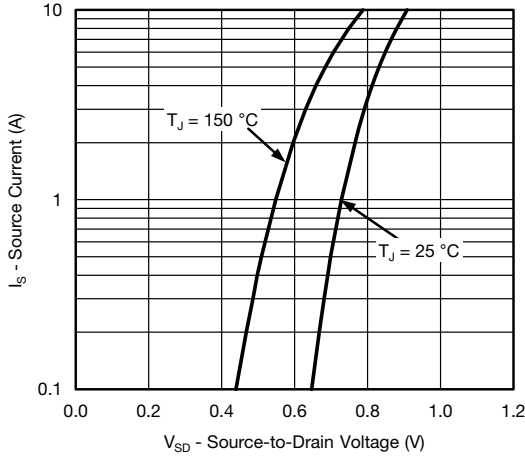


**Gate Charge**

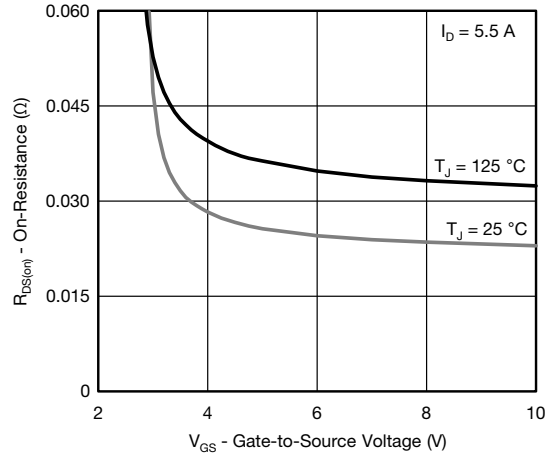


**On-Resistance vs. Junction Temperature**

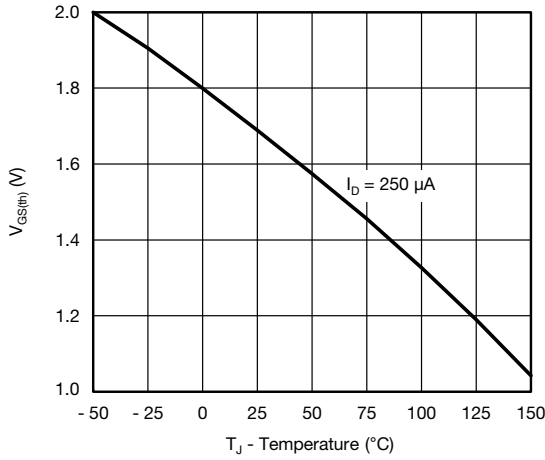
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



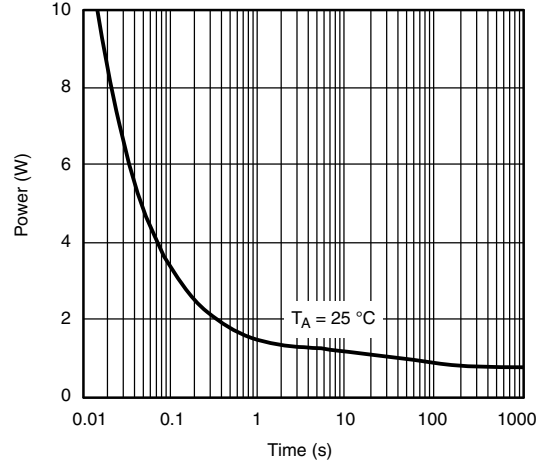
**Source-Drain Diode Forward Voltage**



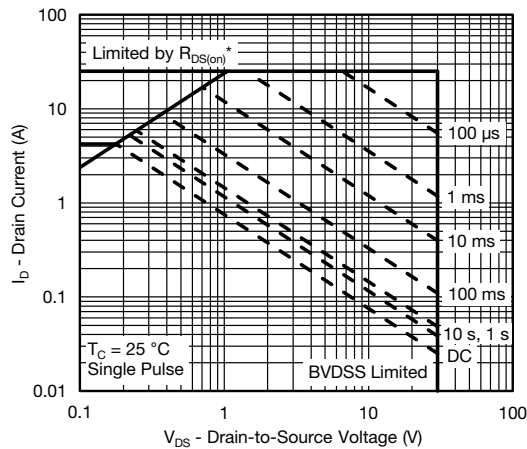
**On-Resistance vs. Gate-to-Source Voltage**



**Threshold Voltage**

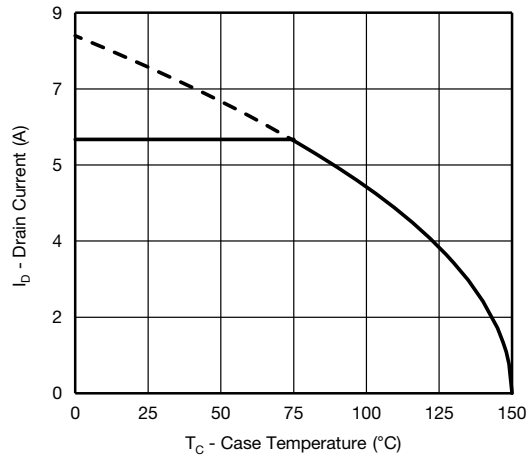


**Single Pulse Power (Junction-to-Ambient)**

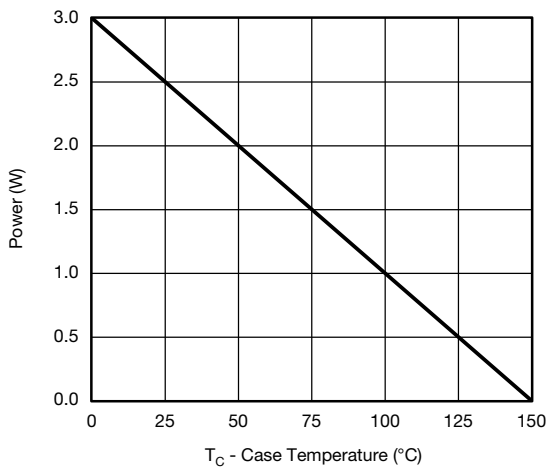


**Safe Operating Area, Junction-to-Ambient**

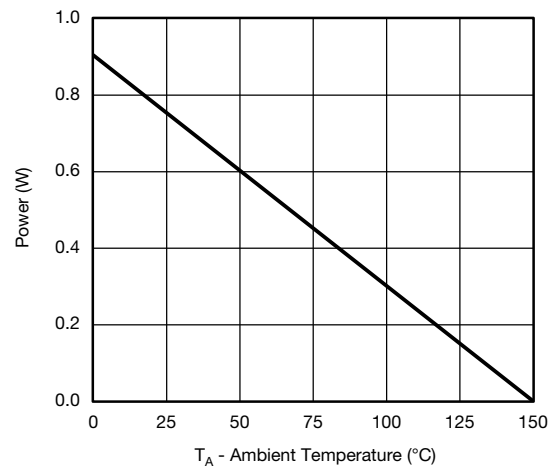
**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



**Current Derating <sup>a</sup>**



**Power Derating, Junction-to-Foot**

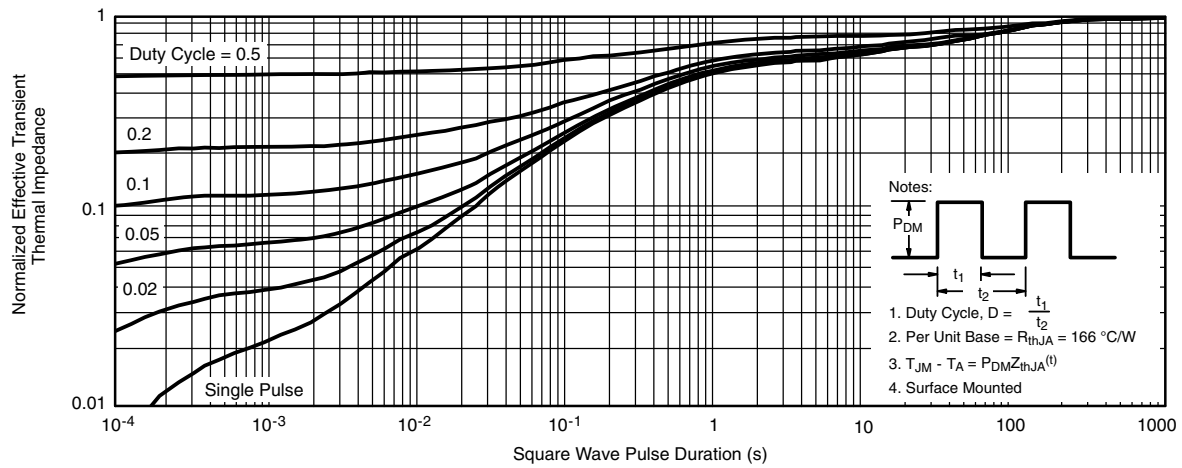


**Power Derating, Junction-to-Ambient**

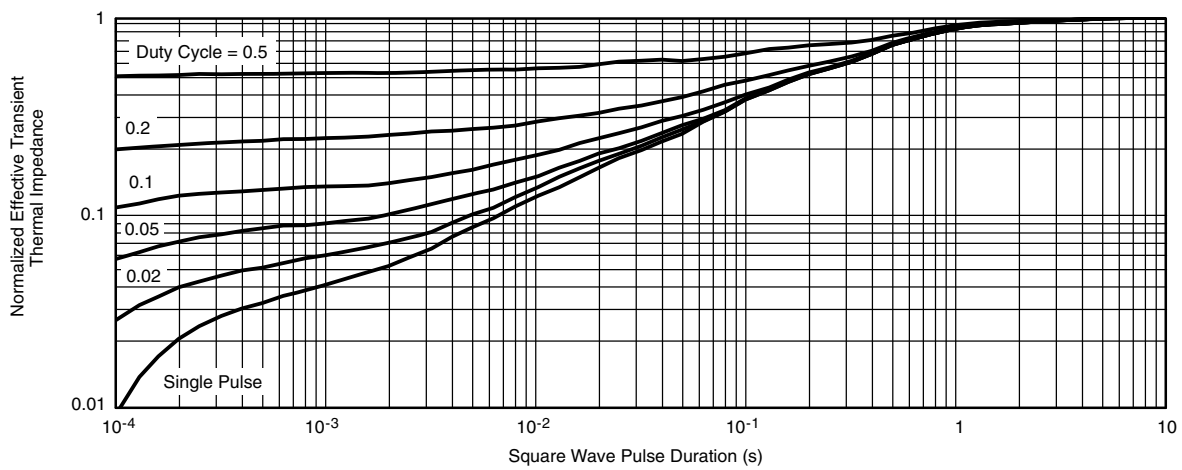
**Note**

- a. The power dissipation P<sub>D</sub> is based on T<sub>J</sub> max. = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.

**TYPICAL CHARACTERISTICS** (25 °C, unless otherwise noted)



**Normalized Thermal Transient Impedance, Junction-to-Ambient**



**Normalized Thermal Transient Impedance, Junction-to-Foot**

**SOT-23 (TO-236): 3-LEAD**



Dim	MILLIMETERS		INCHES	
	Min	Max	Min	Max
A	0.89	1.12	0.035	0.044
A <sub>1</sub>	0.01	0.10	0.0004	0.004
A <sub>2</sub>	0.88	1.02	0.0346	0.040
b	0.35	0.50	0.014	0.020
c	0.085	0.18	0.003	0.007
D	2.80	3.04	0.110	0.120
E	2.10	2.64	0.083	0.104
E <sub>1</sub>	1.20	1.40	0.047	0.055
e	0.95 BSC		0.0374 Ref	
e <sub>1</sub>	1.90 BSC		0.0748 Ref	
L	0.40	0.60	0.016	0.024
L <sub>1</sub>	0.64 Ref		0.025 Ref	
S	0.50 Ref		0.020 Ref	
q	3°	8°	3°	8°

ECN: S-03946-Rev. K, 09-Jul-01  
DWG: 5479

RECOMMENDED MINIMUM PADS FOR SOT-23



Recommended Minimum Pads  
Dimensions in Inches/(mm)

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